Search Notes			

••	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/766,874	YAMASHITA ET AL.
	Examiner	Art Unit
•1	Christopher RoDee	1756

SEARCHED			
Class	Subclass	Date	Examiner
430	111.33 1114.41	1/31/2006	CDR
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH	TES STRATEGY	)
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